

Issue Classification				Application/Control No.		Applicant(s)/Patent under Reexamination	
				10/523,859		CHO ET AL.	
				Examiner		Art Unit	
				David Q. Nguyen		2617	

ORIGINAL				CROSS REFERENCE(S)							
CLASS		SUBCLASS		CLASS		SUBCLASS (ONE SUBCLASS PER BLOCK)					
455		466		455		412.1	433				
INTERNATIONAL CLASSIFICATION											
H	0	4	Q	7/20							
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<i>Nguyen</i> Assistant Examiner) <i>01/05/07</i> (Date)				<i>Joseph Feild</i> JOSEPH FEILD <i>1/16/07</i> SUPERVISORY PATENT EXAMINER (Primary Examiner) <i>1/16/07</i> (Date)				Total Claims Allowed: 4			
								O.G. Print Claim(s) 1	O.G. Print Fig. 5		

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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